

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/646,025 LIN ET AL.	
		Examiner	Art Unit	Page 1 of 1 Christopher Verdier

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,663,604 A	09-1997	Takahashi	310/62
	B	US-6,129,528 A	10-2000	Bradbury et al.	417/423.1
	C	US-5,944,497 A	08-1999	Kershaw et al.	417/423.8
	D	US-4,554,473 A	11-1985	Muller	310/67R
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-6-86,523-A	03-1994	Japan		310/156.26
	O	WO-02/20994-A1	03-2002	WIPO		417/423.8
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.